# MSKSEMI 美森科













ESD

TVS

TSS

MOV

GDT

PLED

BSS84-7-MS

# Product specification





# **General Features**

- -55 V,-0.3A, RDS(ON) =4.0Ω@VGS = 10V
- Improved dv/dt capability
- Fast switching
- Green Device Available
- ESD protected up to 2KV

# Application

- Notebook
- Load Switch
- Battery Protection

# **Reference News**

PACKAGE OUTLINE	Pin Configuration	Marking
SOT-23	G	K84*



# Absolute Maximum Ratings (TA=25 $^\circ\!\!\!\mathrm{C}$ unless otherwise noted)

Symbol	Parameter	Rating	Units
Vds	Drain-Source Voltage	-55	V
Vgs	Gate-Source Voltage	±20	V
D	Drain Current – Continuous (T <sub>A</sub> =25°C)	-0.3	А
	Drain Current – Continuous (T <sub>A</sub> =70°C)	-0.2	А
Ірм	Drain Current – Pulsed <sup>1</sup>	-1.2	А
Po	Power Dissipation (T <sub>A</sub> =25°C)	1.0	W
	Power Dissipation – Derate above 25°C	12.5	mW/°C
Тѕтс	Storage Temperature Range	-55 to 150	°C
TJ	Operating Junction Temperature Range	-55 to 150	°C

#### Thermal Characteristics

Symbol	Parameter	Тур.	Max.	Unit
RθJA	Thermal Resistance Junction to ambient		80	°C <b>/W</b>

## Electrical Characteristics (TJ=25 $^{\circ}$ C , unless otherwise noted)

#### Off Characteristics

Symbol	Parameter	Conditions	Min.	Тур.	Max.	Unit
BVDSS	Drain-Source Breakdown Voltage	Vgs=0V , I₀=-250uA	-55			V
IDSS	Drain-Source Leakage Current	V <sub>DS</sub> =-55V , V <sub>GS</sub> =0V , T <sub>J</sub> =25°C			- 1	uA
1035		Vds=-48V , Vgs=0V , Tj=125°C			- 10	uA
lgss	Gate-Source Leakage Current	Vgs= ±20V , Vds=0V			±20	uA

#### **On Characteristics**

Rds(ON)	Static Drain-Source On-Resistance	Vgs=-10V , Id=-0.3A		4.0	5	Ω
		Vgs=-4.5V , Id=-0.2A		3.5	6.0	
VGS(th)	Gate Threshold Voltage	Vgs=Vds , Id =-250uA	-1.0	- 1.7	-2.5	V
gfs	Forward Transconductance	Vds=-10V , Id=-0.3A		0.4		S



## Dynamic and switching Characteristics

Qg	Total Gate Charge <sup>2,3</sup>			2.8	
Qgs	Gate-Source Charge <sup>2,3</sup>	Vds=-30V , Vgs=-10V , Id=-0.3A		0.96	 nC
Qgd	Gate-Drain Charge <sup>2,3</sup>			0.6	
Td(on)	Turn-On Delay Time <sup>2,3</sup>			3	
Tr	Rise Time <sup>2,3</sup> V <sub>DD</sub> =-30V, V <sub>GS</sub> =-10V, R <sub>G</sub> =6Ω			5	
Td(off)	Turn-Off Delay Time <sup>2,3</sup>	ID=-0.3A		14	 ns
Tf	Fall Time <sup>2,3</sup>			9	
Ciss	Input Capacitance			30.5	
Coss	Output Capacitance	Vds=-30V , Vgs=0V , F=1MHz		15.1	 pF
Crss	Reverse Transfer Capacitance			7	

#### **Drain-Source Diode Characteristics and Maximum Ratings**

Symbol	Parameter Conditions		Min.	Тур.	Max.	Unit
ls	Continuous Source Current				-0.3	А
lsм	Pulsed Source Current	−−−−V <sub>G</sub> =V <sub>D</sub> =0V , Force Current			-0.6	А
Vsd	Diode Forward Voltage	Vgs=0V , Is=-0.2A , Tj=25°C			-1.2	V
Trr	Reverse Recovery Time	Recovery Time VR=-50V, IS=-0.3A		13.5		nS
Qrr	Reverse Recovery Charge	di/dt=100A/ps, TJ=25C		3		nC

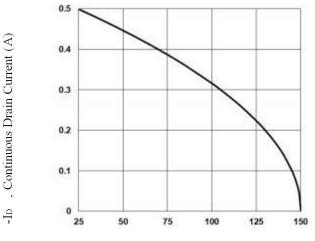
Note :

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.

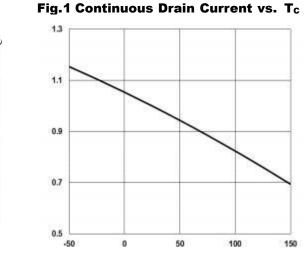
2. The data tested by pulsed , pulse width  $\leq$   $\,$  300us , duty cycle  $\leq$   $\,$  2%  $\,$ 

3. Essentially independent of operating temperature.





 $T_J$ , Junction Temperature (°C)



 $T_J$  , Junction Temperature (°C)

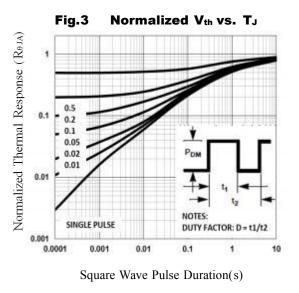
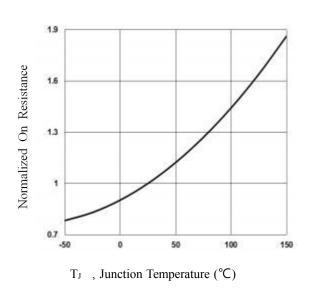


Fig. 5 Normalized Transient Impedance



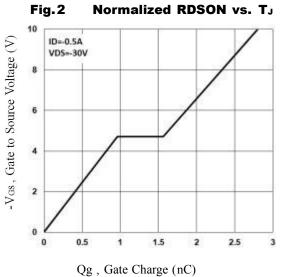


Fig.4 Gate Charge Waveform

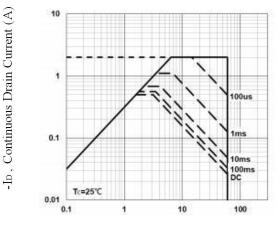
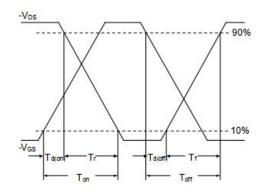
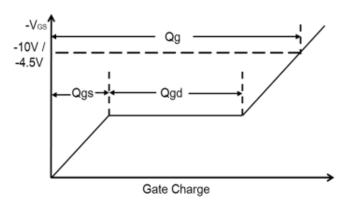




Fig.6 Maximum Safe Operation Area





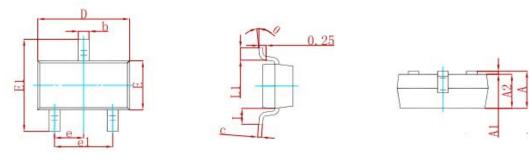






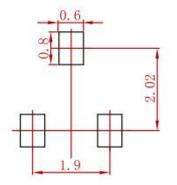


# PACKAGE MECHANICAL DATA



Sumbol	Dimensions	In Millimeters	Dimension	s In Inches
Symbol	Min	Max	Min	Max
A	0.900	1.150	0.035	0.045
A1	0.000	0.100	0.000	0.004
A2	0.900	1.050	0.035	0.041
b	0.300	0.500	0.012	0.020
C	0.080	0.150	0.003	0.006
D	2.800	3.000	0.110	0.118
E	1.200	1.400	0.047	0.055
E1	2.250	2.550	0.089	0.100
e	0.950 TYP		0.037	TYP
e1	1.800	2.000	0.071	0.079
L	0.550	REF	0.022	REF
L1	0.300	0.500	0.012	0.020
θ	0°	8°	0°	8°

**Suggested Pad Layout** 



Note:

1.Controlling dimension: In millimeters.

2.General tolerance:± 0.05mm.

3. The pad layout is for reference purposes only.

#### **REEL SPECIFICATION**

P/N	PKG	QTY
BSS84-7-MS	SOT-23	3000



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